

Search Notes

Application/Control No.

10/715,222

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

MARTIN ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	238	4/29/2006	EMF
375	239	4/29/2006	EMF
375	242	4/29/2006	EMF
375	256	4/29/2006	EMF
375	257	4/29/2006	EMF
375	286	4/29/2006	EMF
375	353	4/29/2006	EMF
307	200.1	4/29/2006	EMF
329	300	4/29/2006	EMF
329	304	4/29/2006	EMF
341	126	4/29/2006	EMF
455	130	4/29/2006	EMF
455	296	4/29/2006	EMF

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	4/29/2006	EMF